

P30924 A05



Sheet 1 of 2

FORM PTO-1449

U.S. Department of Commerce  
Patent and Trademark OfficeAtty. Docket No.  
P30924Application No.  
10/599,615INFORMATION DISCLOSURE STATEMENT  
BY APPLICANT  
(Use several sheets if necessary)Applicant  
Kenichi HAGIO et al.I.A. Filing Date  
July 28, 2005Group  
2878**U.S. PATENT DOCUMENTS**

EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
	1A	6825455	11/30/04	Schwarte			
	1B	2005/0092897	05/05/05	Schwarte			
	1C	5856667	01/05/99	Spirig et al.			
	1D	6057909	05/02/00	Yahav et al.			
	1E	6091905	07/18/00	Yahav et al.			
	1F	6100517	08/08/00	Yahav et al.			
	1G	6445884	09/03/02	Yahav			
	1H	2001/0055482	12/27/01	Braun et al.			
	1I	2004/0114921	06/17/04	Braun et al.			
	1J	7355648	04/08/08	Braun et al.			
	1K	2004/0195493	10/07/04	Hashimoto et al.			
	1L	2005/0178946	08/18/05	Hashimoto et al.			
	1M	7423658	09/09/08	Uomori et al.			

**FOREIGN PATENT DOCUMENTS**

		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES	ENGLISH ABSTRACT YES
	1N	2000-517427	12/26/00	JAPAN				
	1O	10-508736	08/25/98	JAPAN				
	1P	2001-124544	05/11/01	JAPAN			X	X
	1Q	5-45124	02/23/93	JAPAN			X	X
	1R	2003-247805	09/05/03	JAPAN			X	X
	1S	11-508359	07/21/99	JAPAN				
	1T	10-31742	02/03/98	JAPAN			X	X
	1U	2004-309310	11/04/04	JAPAN				
	1V	2004/008175	01/22/04	W.I.P.O.				
	1W	2004-205222	07/22/04	JAPAN			X	X
	1X	2001-209827	08/03/01	JAPAN				
	1Y							

**OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)**

	I	
EXAMINER		DATE CONSIDERED

\*EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

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<b>INFORMATION DISCLOSURE STATEMENT BY APPLICANT</b> (Use several sheets if necessary)		Applicant Kenichi HAGIO et al.	
		I.A. Filing Date July 28, 2005	Group 2878

**U.S. PATENT DOCUMENTS**

EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
	2A	6449004	09/10/02	Okisu et al.			
	2B	2003/0123869	07/03/03	Kohno et al.			
	2C	2005/0145773	07/07/05	Hashimoto et al.			
	2D						
	2E						
	2F						
	2G						
	2H						
	2I						
	2J						
	2K						
	2L						
	2M						

**FOREIGN PATENT DOCUMENTS**

		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES	ENGLISH ABSTRACT YES
	2N	2003-240545	08/27/03	JAPAN			X	X
	2O	9-289611	11/04/97	JAPAN				
	2P	2001-103368	04/13/01	JAPAN			X	X
	2O	2004-180165	06/24/04	JAPAN			X	X
	2R	2003-195155	07/09/03	JAPAN				
	2S	2004-32682	01/29/04	JAPAN				
	2T	2004-45304	02/12/04	JAPAN				
	2U							
	2V							
	2W							
	2X							
	2Y							

**2OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)**

	1	
EXAMINER	DATE CONSIDERED	

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